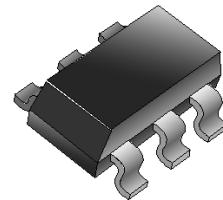


RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

FEATURES

- Trench Power LV MOSFET Technology
- High Dense Cell Design for Low $R_{DS(on)}$
- High Speed Switching
- ESD Protected Up to 2.0KV (HBM)

SOT-26



APPLICATION

- Interfacing, Logic Switch
- Power Management
- Load Switch

MARKING

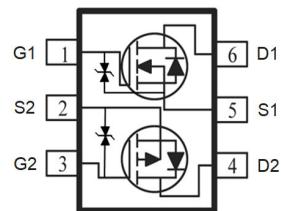
49KA

PACKAGE INFORMATION

Package	MPQ	Leader Size
SOT-26	3K	7 inch

ORDER INFORMATION

Part Number	Type
SST3439E-C	Lead (Pb)-free and Halogen-free



ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating		Unit
		N-Ch	P-Ch	
Drain-Source Voltage	V_{DS}	20	-20	V
Gate-Source Voltage	V_{GS}	± 12	± 12	V
Drain Current	I_D	0.5	-0.5	A
		0.4	-0.4	
Pulsed Drain Current ¹	I_{DM}	2.3	-2.3	A
Total Power Dissipation	P_D	0.3		W
Thermal Resistance from Junction-Ambient ²	$R_{\theta JA}$	416		°C/W
Operating Junction & Storage Temperature Range	T_J, T_{STG}	-55~150		°C

Notes:

1. Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$.
2. Device mounted on FR-4 PCB, 1 inch x 0.85 inch x 0.062 inch

N-CH ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	20	-	-	V	$\text{V}_{GS}=0\text{V}, \text{I}_D=250\mu\text{A}$
Gate Threshold Voltage	$\text{V}_{GS(\text{th})}$	0.35	0.75	1.1	V	$\text{V}_{DS}=\text{V}_{GS}, \text{I}_D=250\mu\text{A}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	1	μA	$\text{V}_{GS}=0\text{V}, \text{V}_{DS}=20\text{V}$
Gate-Body Leakage Current	I_{GSS}	-	± 1.5	± 10	μA	$\text{V}_{GS}= \pm 10\text{V}, \text{V}_{DS}=0\text{V}$
		-	± 0.5	± 2		$\text{V}_{GS}= \pm 8\text{V}, \text{V}_{DS}=0\text{V}$
Static Drain-Source On Resistance	$\text{R}_{DS(\text{ON})}$	-	180	280	$\text{m}\Omega$	$\text{V}_{GS}=4.5\text{V}, \text{I}_D=0.5\text{A}$
		-	250	400		$\text{V}_{GS}=2.5\text{V}, \text{I}_D=0.3\text{A}$
		-	420	650		$\text{V}_{GS}=1.8\text{V}, \text{I}_D=0.2\text{A}$
Total Gate Charge	Q_g	-	1	-	nC	$\text{V}_{DS}=10\text{V}$
Gate-Source Charge	Q_{gs}	-	0.27	-		$\text{V}_{GS}=4.5\text{V}$
Gate-Drain Charge	Q_{gd}	-	0.21	-		$\text{I}_D=0.5\text{A}$
Turn-On Delay Time	$\text{T}_{d(on)}$	-	2.1	-	nS	$\text{V}_{DS}=10\text{V}$
Rise Time	T_r	-	17.5	-		$\text{V}_{GS}=4.5\text{V}$
Turn-Off Delay Time	$\text{T}_{d(off)}$	-	9.5	-		$\text{I}_D=0.5\text{A}$
Fall Time	T_f	-	22	-		$\text{R}_G=10\Omega$
Input Capacitance	C_{iss}	-	52	-	pF	$\text{V}_{DS}=10\text{V}$
Output Capacitance	C_{oss}	-	19	-		$\text{V}_{GS}=0\text{V}$
Reverse Transfer Capacitance	C_{rss}	-	2.3	-		f=1MHz

Source Drain Diode

Maximum Body-Diode Continuous Current	I_s		-	0.5	A	
Diode Forward Voltage	V_{SD}	-	-	1.2	V	$\text{I}_s=0.5\text{A}, \text{V}_{GS}=0$
Reverse Recovery Time	t_{rr}		14		nS	$\text{I}_F=0.5\text{A}, \text{di}/\text{dt}=20\text{A}/\mu\text{s}$
Reverse Recovery Charge	Q_{rr}		0.39		nC	

P-CH ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	-20	-	-	V	$\text{V}_{GS}=0\text{V}, \text{I}_D= -250\mu\text{A}$
Gate Threshold Voltage	$\text{V}_{GS(\text{th})}$	-0.35	-0.62	-1.2	V	$\text{V}_{DS}=\text{V}_{GS}, \text{I}_D= -250\mu\text{A}$
Zero Gate Voltage Drain Current	I_{DSS}	-	-	-1	μA	$\text{V}_{GS}=0\text{V}, \text{V}_{DS}= -20\text{V}, \text{T}_C=25^\circ\text{C}$
Gate-Body Leakage Current	I_{GSS}	-	± 1.5	± 10	μA	$\text{V}_{GS}= \pm 10\text{V}, \text{V}_{DS}=0\text{V}$
		-	± 0.5	± 2		$\text{V}_{GS}= \pm 8\text{V}, \text{V}_{DS}=0\text{V}$
Static Drain-Source On Resistance	$\text{R}_{DS(\text{ON})}$	-	610	850	$\text{m}\Omega$	$\text{V}_{GS}= -4.5\text{V}, \text{I}_D= -0.5\text{A}$
		-	930	1200		$\text{V}_{GS}= -2.5\text{V}, \text{I}_D= -0.3\text{A}$
		-	1100	1700		$\text{V}_{GS}= -1.8\text{V}, \text{I}_D= -0.2\text{A}$
Total Gate Charge	Q_g	-	1.22	-	nC	$\text{V}_{DD}= -10\text{V}$
Gate-Source Charge	Q_{gs}	-	0.36	-		$\text{V}_{GS}= -4.5\text{V}$
Gate-Drain Charge	Q_{gd}	-	0.26	-		$\text{I}_D= -0.5\text{A}$
Turn-On Delay Time	$\text{T}_{d(on)}$	-	4.5	-	nS	$\text{V}_{DD}= -10\text{V}$
Rise Time	T_r	-	18	-		$\text{V}_{GS}= -4.5\text{V}$
Turn-Off Delay Time	$\text{T}_{d(off)}$	-	15	-		$\text{R}_L=2.5\Omega$
Fall Time	T_f	-	23	-		$\text{R}_{GEN}=3\Omega$
Input Capacitance	C_{iss}	-	70	-	pF	$\text{V}_{DS}= -10\text{V}$
Output Capacitance	C_{oss}	-	19	-		$\text{V}_{GS}=0\text{V}$
Reverse Transfer Capacitance	C_{rss}	-	14	-		f=1MHz

Source Drain Diode

Maximum Body-Diode Continuous Current	I_s		-	-0.5	A	
Diode Forward Voltage	V_{SD}	-	-	-1.2	V	$\text{I}_s= -0.5\text{A}, \text{V}_{GS}=0$
Reverse Recovery Time	t_{rr}		24		nS	
Reverse Recovery Charge	Q_{rr}		0.95		nC	$\text{IF}= -0.5\text{A}, \text{di/dt}= -20\text{A}/\mu\text{s}$

N-CH TYPICAL CHARACTERISTIC CURVE

Figure 1. Output Characteristics

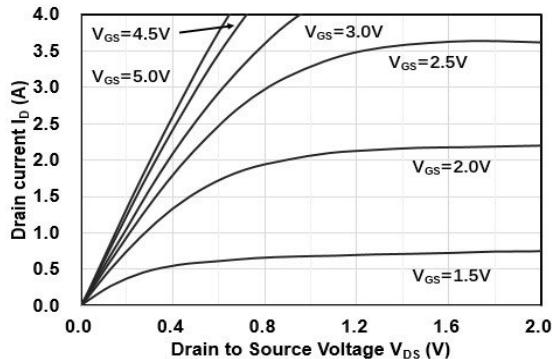


Figure 2. Transfer Characteristics

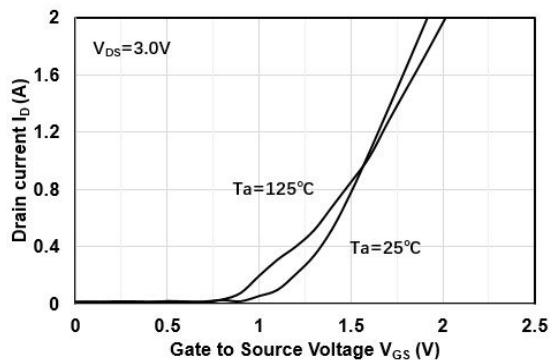


Figure 3. Capacitance Characteristics

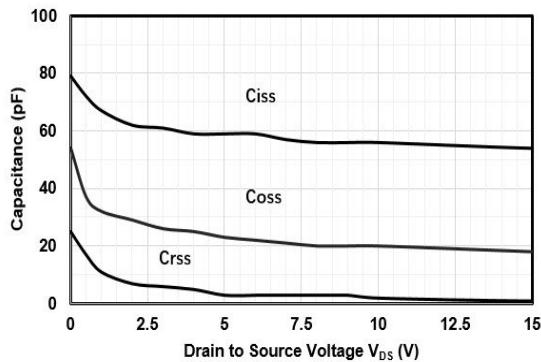


Figure 4. Gate Charge

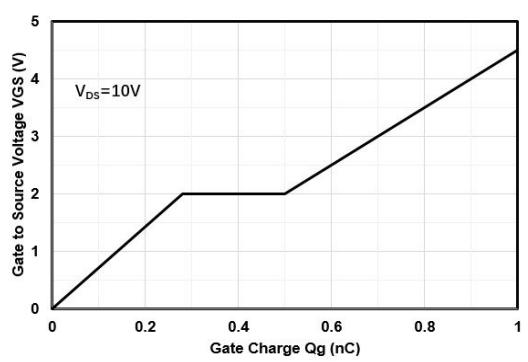


Figure 5. Drain-Source on Resistance

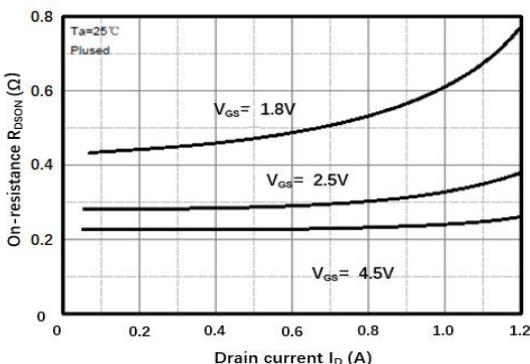


Figure 6. Drain-Source on Resistance

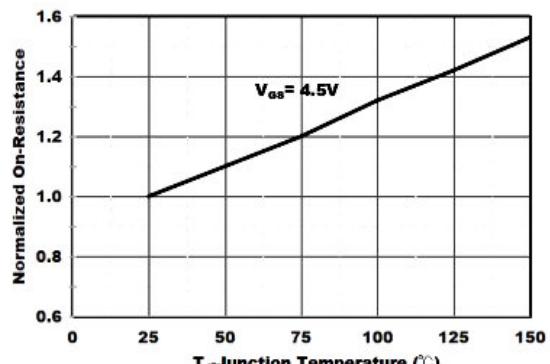


Figure 7. Safe Operation Area

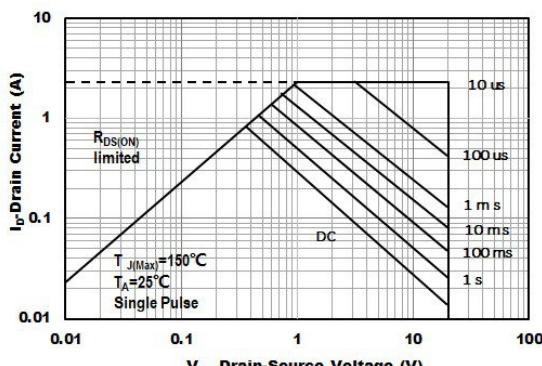
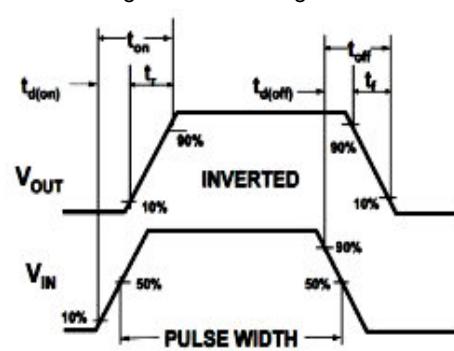


Figure 8. Switching wave



P-CH TYPICAL CHARACTERISTIC CURVE

Figure 1. Output Characteristics

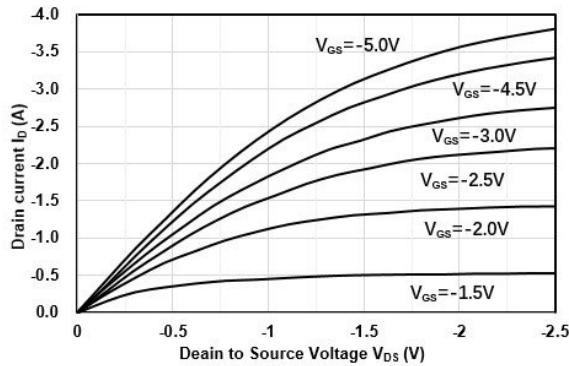


Figure 3. Capacitance Characteristics

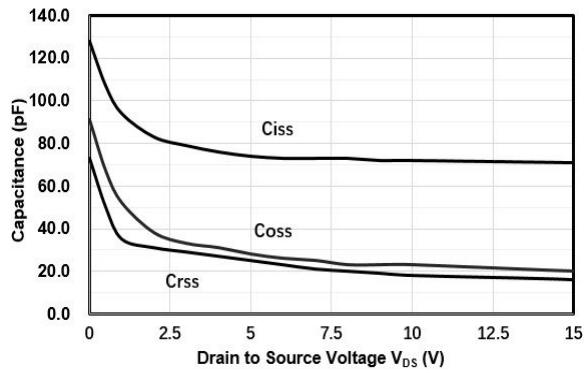


Figure 5. Drain-Source on Resistance

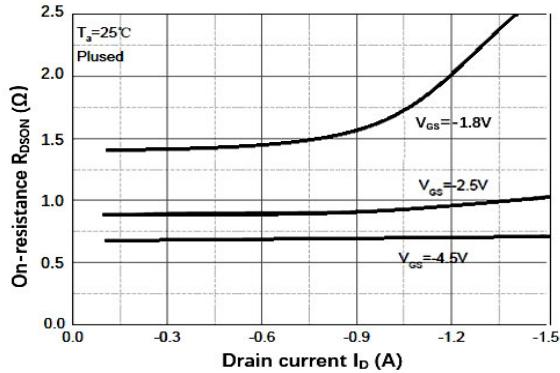


Figure 7. Safe Operation Area

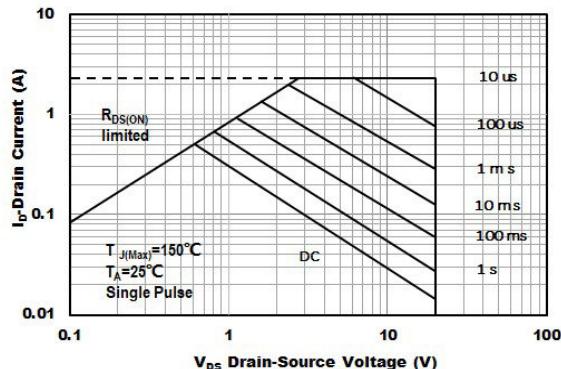


Figure 2. Transfer Characteristics

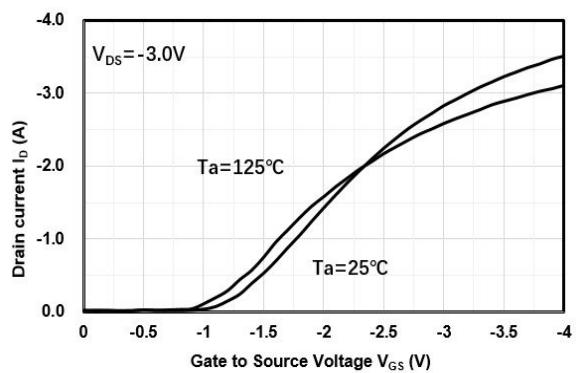


Figure 4. Gate Charge

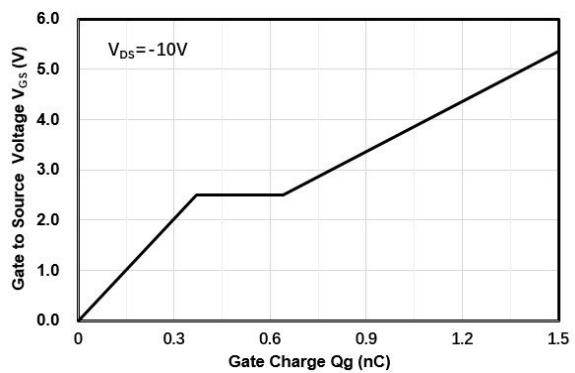


Figure 6. Drain-Source on Resistance

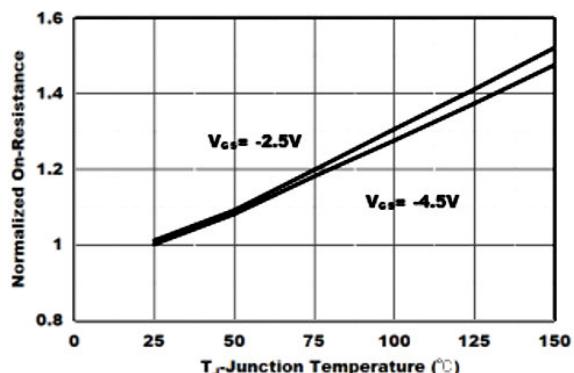
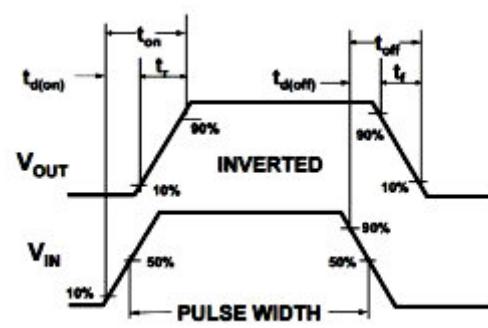
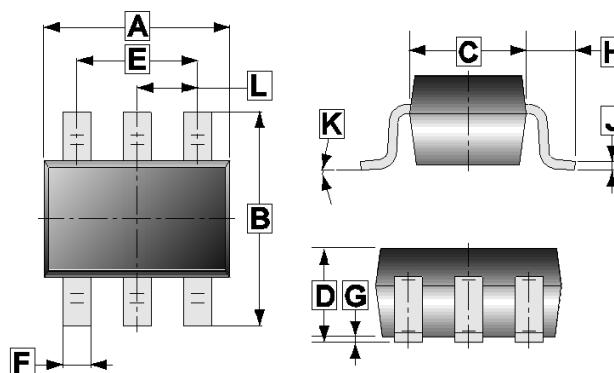


Figure 8. Switching wave



PACKAGE OUTLINE DIMENSIONS

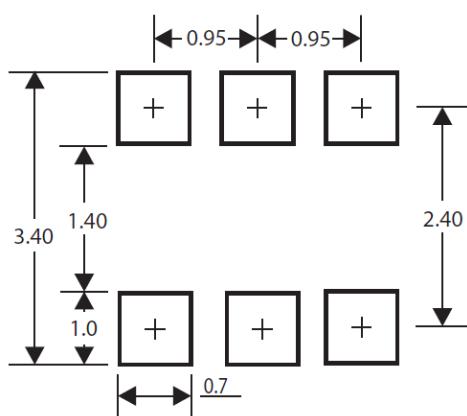
SOT-26



REF.	Millimeter	
	Min.	Max.
A	2.70	3.10
B	2.60	3.00
C	1.40	1.80
D	-	1.30
E	1.90 REF.	
F	0.25	0.50
G	0	0.10
H	0.60 REF.	
J	0.12 REF.	
K	0°	10°
L	0.95 REF.	

MOUNTING PAD LAYOUT

SOT-26



*Dimensions in millimeters